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### Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

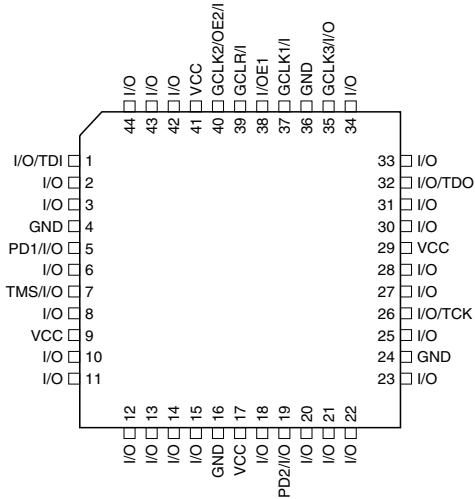
Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

### Applications of Embedded - CPLDs

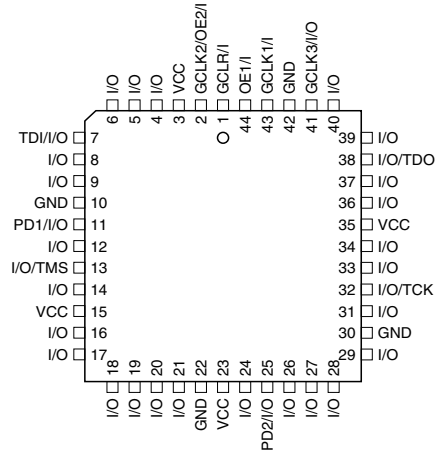
#### Details

Product Status	Obsolete
Programmable Type	In System Programmable (min 10K program/erase cycles)
Delay Time tpd(1) Max	20 ns
Voltage Supply - Internal	3V ~ 3.6V
Number of Logic Elements/Blocks	-
Number of Macrocells	64
Number of Gates	-
Number of I/O	32
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-LCC (J-Lead)
Supplier Device Package	44-PLCC (16.6x16.6)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/atf1504asvl-20ji44">https://www.e-xfl.com/product-detail/microchip-technology/atf1504asvl-20ji44</a>

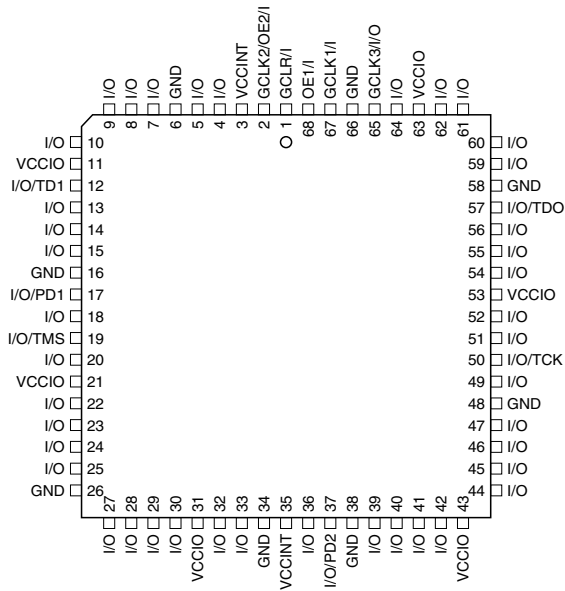
**44-lead TQFP  
Top View**



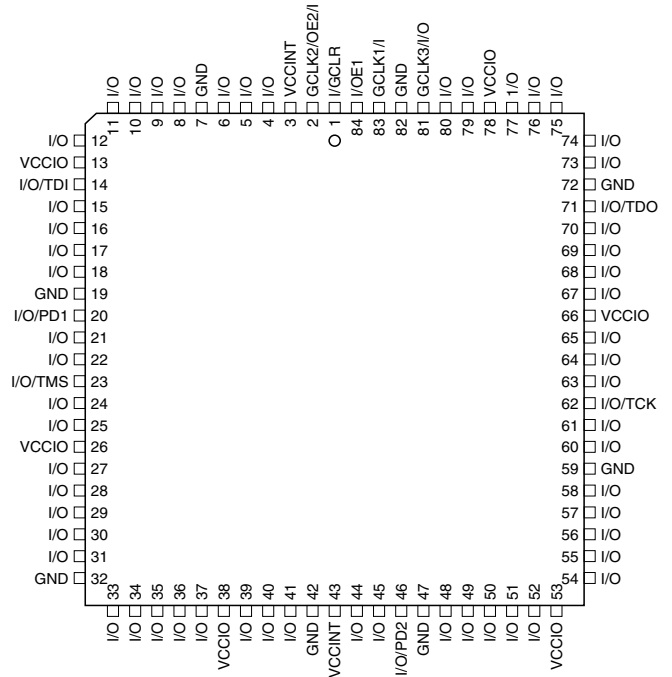
**44-lead PLCC  
Top View**



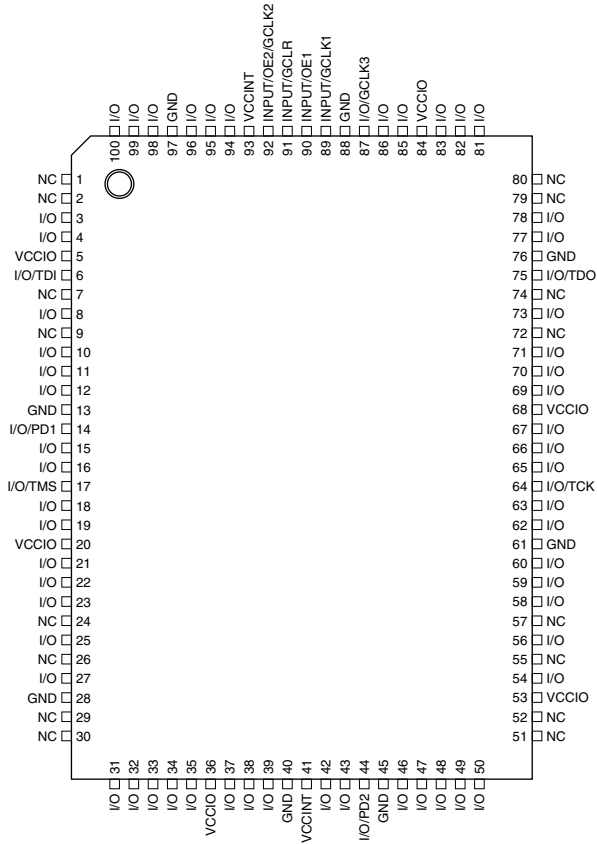
**68-lead PLCC  
Top View**



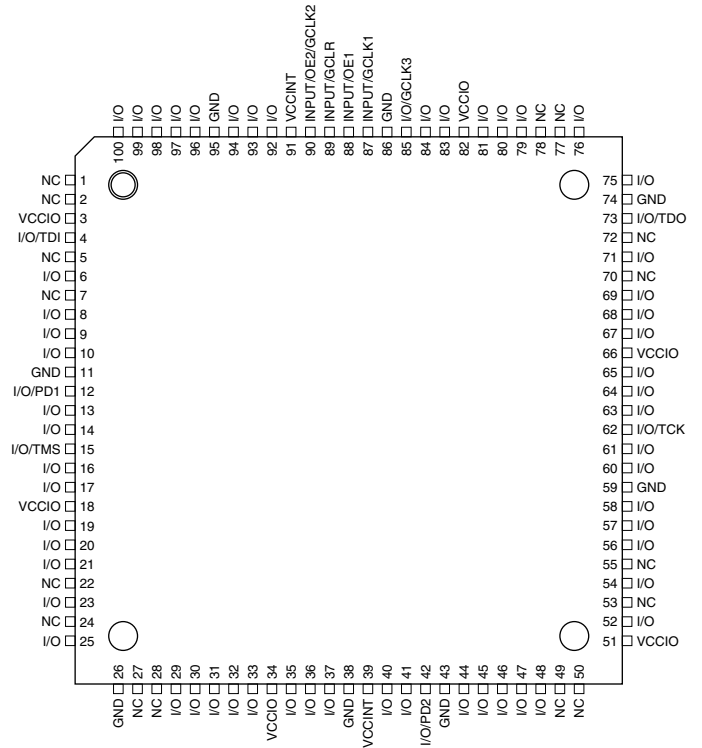
**84-lead PLCC  
Top View**



**100-lead PQFP  
Top View**



**100-lead TQFP  
Top View**





## **OR/XOR/CASCADE Logic**

The ATF1504ASV(L)'s logic structure is designed to efficiently support all types of logic. Within a single macrocell, all the product terms can be routed to the OR gate, creating a 5-input AND/OR sum term. With the addition of the CASIN from neighboring macrocells, this can be expanded to as many as 40 product terms with little additional delay.

The macrocell's XOR gate allows efficient implementation of compare and arithmetic functions. One input to the XOR comes from the OR sum term. The other XOR input can be a product term or a fixed high- or low-level. For combinatorial outputs, the fixed level input allows polarity selection. For registered functions, the fixed levels allow DeMorgan minimization of product terms. The XOR gate is also used to emulate T- and JK-type flip-flops.

## **Flip-flop**

The ATF1504ASV(L)'s flip-flop has very flexible data and control functions. The data input can come from either the XOR gate, from a separate product term or directly from the I/O pin. Selecting the separate product term allows creation of a buried registered feedback within a combinatorial output macrocell. (This feature is automatically implemented by the fitter software). In addition to D, T, JK and SR operation, the flip-flop can also be configured as a flow-through latch. In this mode, data passes through when the clock is high and is latched when the clock is low.

The clock itself can either be one of the Global CLK Signal (GCK[0 : 2]) or an individual product term. The flip-flop changes state on the clock's rising edge. When the GCK signal is used as the clock, one of the macrocell product terms can be selected as a clock enable. When the clock enable function is active and the enable signal (product term) is low, all clock edges are ignored. The flip-flop's asynchronous reset signal (AR) can be either the Global Clear (GCLEAR), a product term, or always off. AR can also be a logic OR of GCLEAR with a product term. The asynchronous preset (AP) can be a product term or always off.

## **Extra Feedback**

The ATF1504ASV(L) macrocell output can be selected as registered or combinatorial. The extra buried feedback signal can be either combinatorial or a registered signal regardless of whether the output is combinatorial or registered. (This enhancement function is automatically implemented by the fitter software.) Feedback of a buried combinatorial output allows the creation of a second latch within a macrocell.

## **I/O Control**

The output enable multiplexer (MOE) controls the output enable signal. Each I/O can be individually configured as an input, output or for bi-directional operation. The output enable for each macrocell can be selected from the true or compliment of the two output enable pins, a subset of the I/O pins, or a subset of the I/O macrocells. This selection is automatically done by the fitter software when the I/O is configured as an input, all macrocell resources are still available, including the buried feedback, expander and cascade logic.

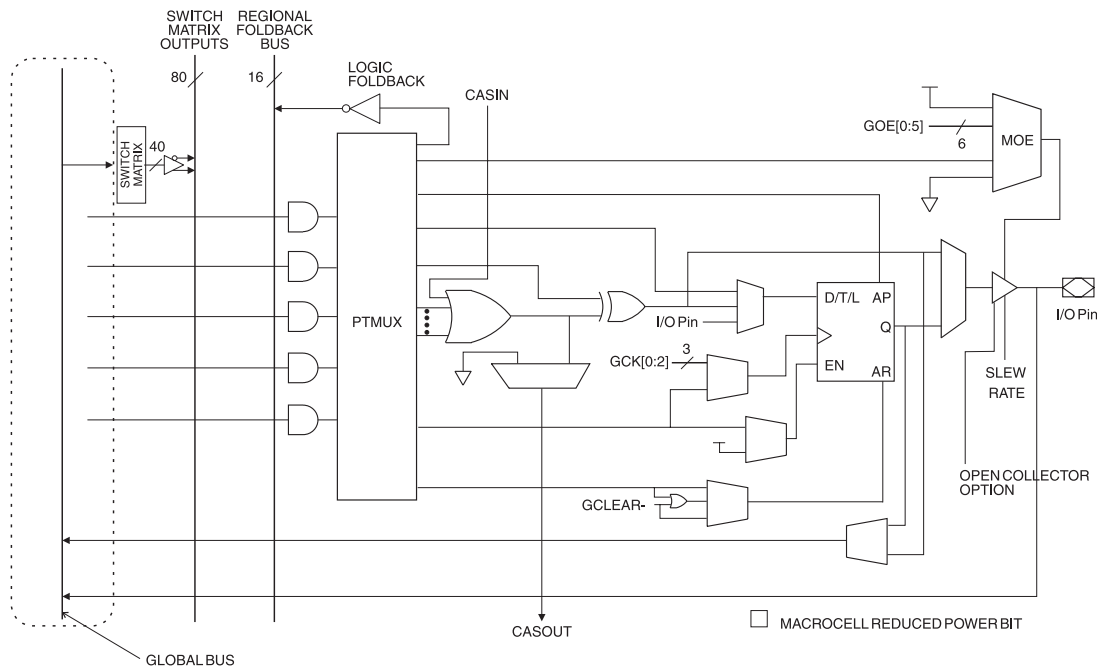
## **Global Bus/Switch Matrix**

The global bus contains all input and I/O pin signals as well as the buried feedback signal from all 64 macrocells. The switch matrix in each logic block receives as its inputs all signals from the global bus. Under software control, up to 40 of these signals can be selected as inputs to the logic block.

## **Foldback Bus**

Each macrocell also generates a foldback product term. This signal goes to the regional bus and is available to four macrocells. The foldback is an inverse polarity of one of the macrocell's product terms. The four foldback terms in each region allow generation of high fan-in sum terms (up to nine product terms) with little additional delay.

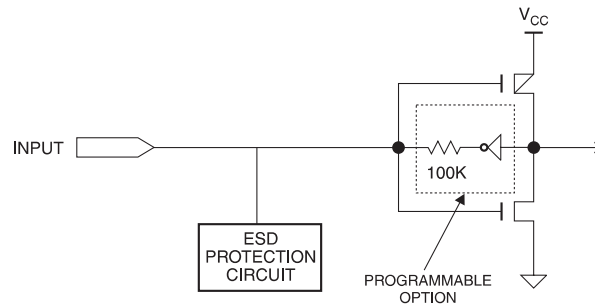
**Figure 1. ATF1504ASV(L) Macrocell**



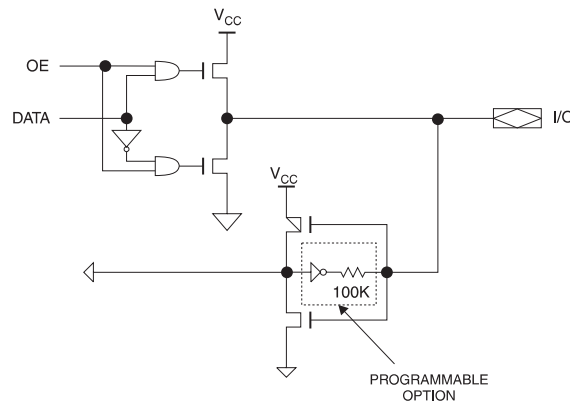
## Programmable Pin-keeper Option for Inputs and I/Os

The ATF1504ASV(L) offers the option of programming all input and I/O pins so that pin keeper circuits can be utilized. When any pin is driven high or low and then subsequently left floating, it will stay at that previous high- or low-level. This circuitry prevents unused input and I/O lines from floating to intermediate voltage levels, which causes unnecessary power consumption and system noise. The keeper circuits eliminate the need for external pull-up resistors and eliminate their DC power consumption.

## Input Diagram



## I/O Diagram



## Speed/Power Management

The ATF1504ASV(L) has several built-in speed and power management features. The ATF1504ASV(L) contains circuitry that automatically puts the device into a low power standby mode when no logic transitions are occurring. This not only reduces power consumption during inactive periods, but also provides proportional power savings for most applications running at system speeds below 5 MHz. This feature may be selected as a device option.

To further reduce power, each ATF1504ASV(L) macrocell has a reduced-power bit feature. This feature allows individual macrocells to be configured for maximum power savings. This feature may be selected as a design option.

All ATF1504ASV(L) also have an optional power-down mode. In this mode, current drops to below 5 mA. When the power-down option is selected, either PD1 or PD2 pins (or both) can be used to power down the part. The power-down option is selected in the design source file. When enabled, the device goes into power down when either PD1 or PD2 is high. In the power-down mode, all internal logic signals are latched and held, as are any enabled outputs.

All pin transitions are ignored until the PD pin is brought low. When the power-down feature is enabled, the PD1 or PD2 pin cannot be used as a logic input or output. However, the pin's macrocell may still be used to generate buried foldback and cascade logic signals.

All power-down AC characteristic parameters are computed from external input or I/O pins, with reduced-power bit turned on. For macrocells in reduced-power mode (reduced-power bit turned on), the reduced-power adder,  $t_{RPA}$ , must be added to the AC parameters, which include the data paths  $t_{LAD}$ ,  $t_{LAC}$ ,  $t_{IC}$ ,  $t_{ACL}$ ,  $t_{ACH}$  and  $t_{SEXP}$ .

The ATF1504ASV(L) macrocell also has an option whereby the power can be reduced on a per macrocell basis. By enabling this power-down option, macrocells that are not used in an application can be turned down, thereby reducing the overall power consumption of the device.

Each output also has individual slew rate control. This may be used to reduce system noise by slowing down outputs that do not need to operate at maximum speed. Outputs default to slow switching, and may be specified as fast switching in the design file.

## Design Software Support

ATF1504ASV(L) designs are supported by several industry standard third party tools. Automated fitters allow logic synthesis using a variety of high-level description languages and formats.

## Power-up Reset

The ATF1504ASV is designed with a power-up reset, a feature critical for state machine initialization. At a point delayed slightly from  $V_{CC}$  crossing  $V_{RST}$ , all registers will be initialized, and the state of each output will depend on the polarity of its buffer. However, due to the asynchronous nature of reset and uncertainty of how  $V_{CC}$  actually rises in the system, the following conditions are required:

1. The  $V_{CC}$  rise must be monotonic,
2. After reset occurs, all input and feedback setup times must be met before driving the clock pin high, and,
3. The clock must remain stable during  $T_D$ .

The ATF1504ASV has two options for the hysteresis about the reset level,  $V_{RST}$ , Small and Large. To ensure a robust operating environment in applications where the device is operated near 3.0V, Atmel recommends that during the fitting process users configure the device with the Power-up Reset hysteresis set to Large. For conversions, Atmel POF2JED users should include the flag “-power\_reset” on the command line after “file-name.POF”. To allow the registers to be properly reinitialized with the Large hysteresis option selected, the following condition is added:

4. If  $V_{CC}$  falls below 2.0V, it must shut off completely before the device is turned on again.

When the Large hysteresis option is active,  $I_{CC}$  is reduced by several hundred microamps as well.

## Security Fuse Usage

A single fuse is provided to prevent unauthorized copying of the ATF1504ASV(L) fuse patterns. Once programmed, fuse verify is inhibited. However, the 16-bit User Signature remains accessible.

## DC and AC Operating Conditions

	Commercial	Industrial
Operating Temperature (Ambient)	0°C - 70°C	-40°C - 85°C
V <sub>CC</sub> (3.3V) Power Supply	3.0V - 3.6V	3.0V - 3.6V

## DC Characteristics

Symbol	Parameter	Condition			Min	Typ	Max	Units
I <sub>IL</sub>	Input or I/O Low Leakage Current	V <sub>IN</sub> = V <sub>CC</sub>				-2	-10	μA
I <sub>IH</sub>	Input or I/O High Leakage Current					2	10	
I <sub>OZ</sub>	Tri-State Output Off-State Current	V <sub>O</sub> = V <sub>CC</sub> or GND			-40		40	μA
I <sub>CC1</sub>	Power Supply Current, Standby	V <sub>CC</sub> = Max V <sub>IN</sub> = 0, V <sub>CC</sub>	Std Mode	Com.		60		mA
				Ind.		75		mA
			“L” Mode	Com.		5		μA
				Ind.		5		μA
I <sub>CC2</sub>	Power Supply Current, Power-down Mode	V <sub>CC</sub> = Max V <sub>IN</sub> = 0, V <sub>CC</sub>	“PD” Mode			0.1	5	mA
I <sub>CC3</sub> <sup>(2)</sup>	Reduced-power Mode Supply Current, Standby	V <sub>CC</sub> = Max V <sub>IN</sub> = 0, V <sub>CC</sub>	Std Power	Com		40		ma
				Ind		55		
V <sub>IL</sub>	Input Low Voltage				-0.3		0.8	V
V <sub>IH</sub>	Input High Voltage				1.7		V <sub>CCIO</sub> + 0.3	V
V <sub>OL</sub>	Output Low Voltage (TTL)	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>CCIO</sub> = Min, I <sub>OL</sub> = 8 mA		Com.			0.45	V
				Ind.			0.45	
	Output Low Voltage (CMOS)	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>CC</sub> = Min, I <sub>OL</sub> = 0.1 mA		Com.			0.2	V
				Ind.			0.2	V
V <sub>OH</sub>	Output High Voltage - 3.3V (TTL)	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>CCIO</sub> = Min, I <sub>OH</sub> = -2.0 mA			2.4			V
	Output High Voltage - 3.3V (CMOS)	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>CCIO</sub> = Min, I <sub>OH</sub> = -0.1 mA			V <sub>CCIO</sub> - 0.2			V

Notes: 1. Not more than one output at a time should be shorted. Duration of short circuit test should not exceed 30 sec.  
2. When microcell reduced-power feature is enabled.

## Pin Capacitance

	Typ	Max	Units	Conditions
C <sub>IN</sub>		8	pF	V <sub>IN</sub> = 0V; f = 1.0 MHz
C <sub>I/O</sub>		8	pF	V <sub>OUT</sub> = 0V; f = 1.0 MHz

Note: Typical values for nominal supply voltage. This parameter is only sampled and is not 100% tested.  
The OGI pin (high-voltage pin during programming) has a maximum capacitance of 12 pF.



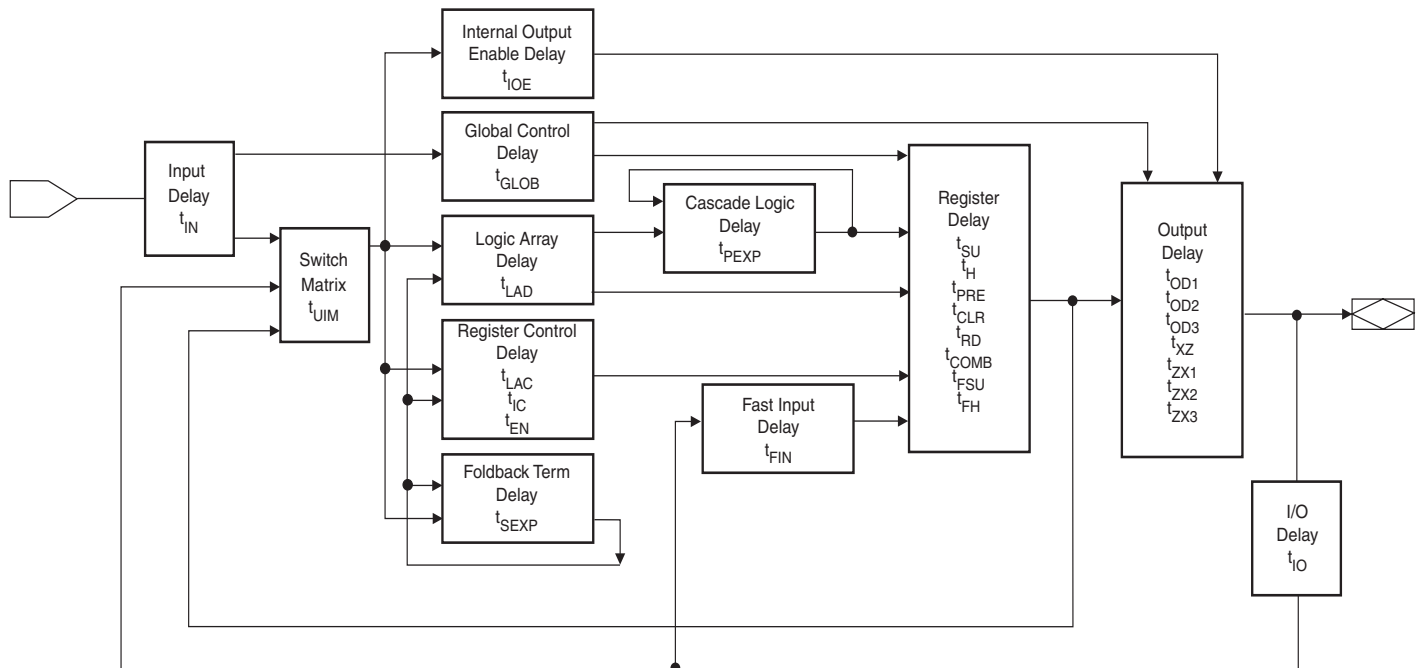
## Absolute Maximum Ratings\*

Temperature Under Bias .....	-40°C to +85°C
Storage Temperature .....	-65°C to +150°C
Voltage on Any Pin with Respect to Ground .....	-2.0V to +7.0V <sup>(1)</sup>
Voltage on Input Pins with Respect to Ground During Programming .....	-2.0V to +14.0V <sup>(1)</sup>
Programming Voltage with Respect to Ground .....	-2.0V to +14.0V <sup>(1)</sup>

**\*NOTICE:** Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Note:** 1. Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is  $V_{CC} + 0.75V$  DC, which may overshoot to 7.0V for pulses of less than 20 ns.

## Timing Model



## Power-down Mode

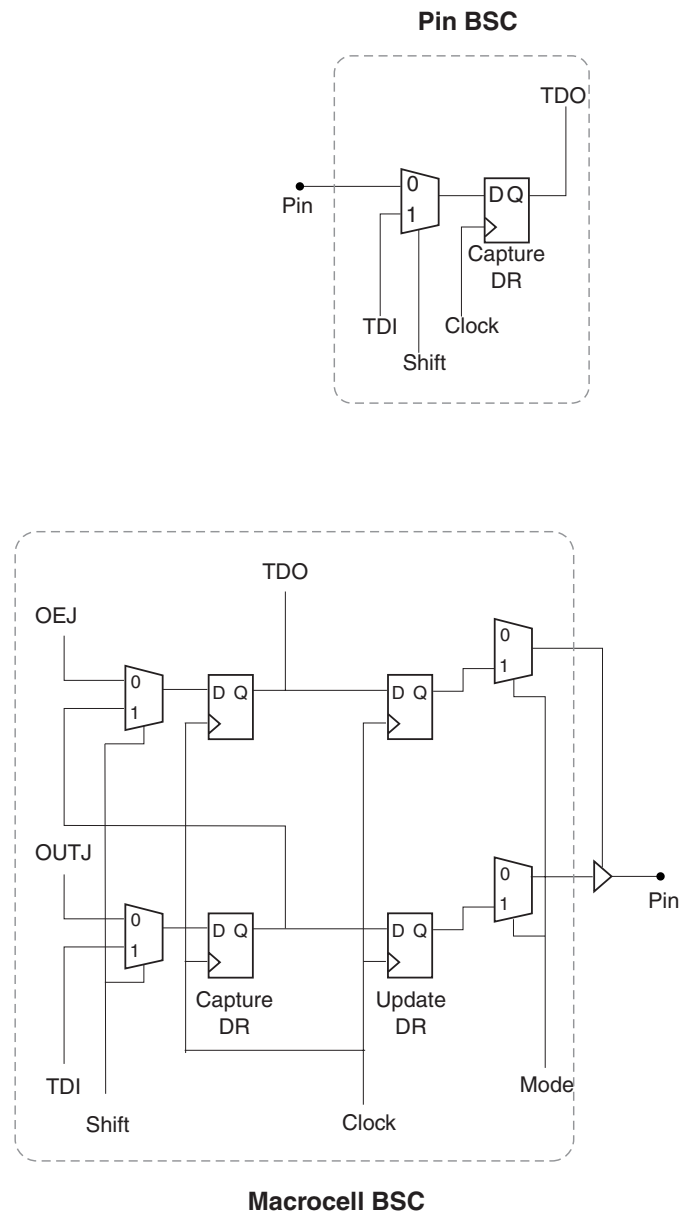
The ATF1504ASV(L) includes an optional pin-controlled power-down feature. When this mode is enabled, the PD pin acts as the power-down pin. When the PD pin is high, the device supply current is reduced to less than 3 mA. During power down, all output data and internal logic states are latched internally and held. Therefore, all registered and combinatorial output data remain valid. Any outputs that were in a High-Z state at the onset will remain at High-Z. During power down, all input signals except the power-down pin are blocked. Input and I/O hold latches remain active to ensure that pins do not float to indeterminate levels, further reducing system power. The power-down mode feature is enabled in the logic design file or as a fitted or translated s/w option. Designs using the power-down pin may not use the PD pin as a logic array input. However, all other PD pin macrocell resources may still be used, including the buried feedback and foldback product term array inputs.

## Power Down AC Characteristics<sup>(1)(2)</sup>

Symbol	Parameter	-15		-20		Units
		Min	Max	Min	Max	
$t_{IVDH}$	Valid I, I/O before PD High	15		20		ns
$t_{GVDH}$	Valid OE <sup>(2)</sup> before PD High	15		20		ns
$t_{CVDH}$	Valid Clock <sup>(2)</sup> before PD High	15		20		ns
$t_{DHIX}$	I, I/O Don't Care after PD High		25		30	ns
$t_{DHGX}$	OE <sup>(2)</sup> Don't Care after PD High		25		30	ns
$t_{DHCX}$	Clock <sup>(2)</sup> Don't Care after PD High		25		30	ns
$t_{DLIV}$	PD Low to Valid I, I/O		1		1	μs
$t_{DLGV}$	PD Low to Valid OE (Pin or Term)		1		1	μs
$t_{DLCV}$	PD Low to Valid Clock (Pin or Term)		1		1	μs
$t_{DLOV}$	PD Low to Valid Output		1		1	μs

- Notes:
1. For slow slew outputs, add  $t_{SSO}$ .
  2. Pin or product term.
  3. Includes  $t_{RPA}$  for reduced-power bit enabled.

## BSC Configuration for Macrocell



## ATF1504ASV Dedicated Pinouts

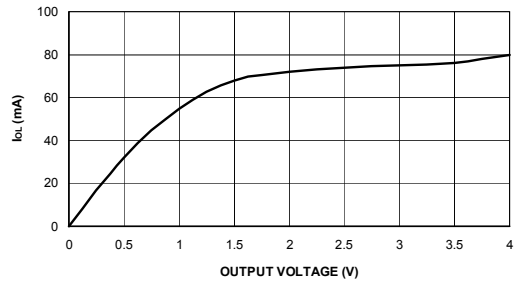
Dedicated Pin	44-lead TQFP	44-lead J-lead	68-lead J-lead	84-lead J-lead	100-lead PQFP	100-lead TQFP
INPUT/OE2/GCLK2	40	2	2	2	92	90
INPUT/GCLR	39	1	1	1	91	89
INPUT/OE1	38	44	68	84	90	88
INPUT/GCLK1	37	43	67	83	89	87
I/O /GCLK3	35	41	65	81	87	85
I/O / PD (1,2)	5, 19	11, 25	17, 37	20, 46	14, 44	12, 42
I/O / TDI (JTAG)	1	7	12	14	6	4
I/O / TMS (JTAG)	7	13	19	23	17	15
I/O / TCK (JTAG)	26	32	50	62	64	62
I/O / TDO (JTAG)	32	38	57	71	75	73
GND	4, 16, 24, 36	10, 22, 30, 42	6, 16, 26, 34, 38, 48, 58, 66	7, 19, 32, 42, 47, 59, 72, 82	13, 28, 40, 45, 61, 76, 88, 97	11, 26, 38, 43, 59, 74, 86, 95
V <sub>CC</sub>	9, 17, 29, 41	3, 15, 23, 35	3, 11, 21, 31, 35, 43, 53, 63	3, 13, 26, 38, 43, 53, 66, 78	5, 20, 36, 41, 53, 68, 84, 93	3, 18, 34, 39, 51, 66, 82, 91
N/C	—	—	—	—	1, 2, 7, 9, 24, 26, 29, 30, 51, 52, 55, 57, 72, 74, 79, 80	1, 2, 5, 7, 22, 24, 27, 28, 49, 50, 53, 55, 70, 72, 77, 78
# of Signal Pins	36	36	52	68	68	68
# User I/O Pins	32	32	48	64	64	64

OE (1, 2) Global OE pins  
 GCLR Global Clear pin  
 GCLK (1, 2, 3) Global Clock pins  
 PD (1, 2) Power-down pins  
 TDI, TMS, TCK, TDO JTAG pins used for boundary-scan testing or in-system programming  
 GND Ground pins  
 VCC VCC pins for the device

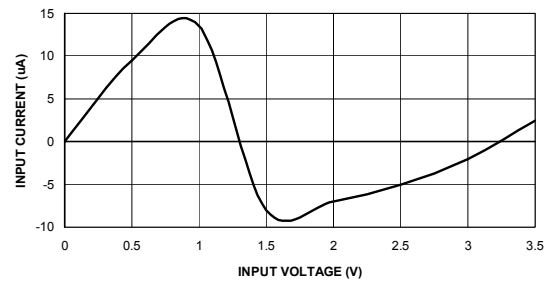
## ATF1504ASV I/O Pinouts

MC	PLC	44-lead PLCC	44-lead TQFP	68-lead PLCC	84-lead PLCC	100- lead PQFP	100- lead TQFP	MC	PLC	44-lead PLCC	44-lead TQFP	68-lead PLCC	84-lead PLCC	100- lead PQFP	100- lead TQFP
1	A	12	6	18	22	16	14	33	C	24	18	36	44	42	40
2	A	-	-	-	21	15	13	34	C	-	-	-	45	43	41
3	A/ PD1	11	5	17	20	14	12	35	C/ PD2	25	19	37	46	44	42
4	A	9	3	15	18	12	10	36	C	26	20	39	48	46	44
5	A	8	2	14	17	11	9	37	C	27	21	40	49	47	45
6	A	-	-	13	16	10	8	38	C	-	-	41	50	48	46
7	A	-	-	-	15	8	6	39	C	-	-	-	51	49	47
8/ TDI	A	7	1	12	14	6	4	40	C	28	22	42	52	50	48
9	A	-	-	10	12	4	100	41	C	29	23	44	54	54	52
10	A	-	-	-	11	3	99	42	C	-	-	-	55	56	54
11	A	6	44	9	10	100	98	43	C	-	-	45	56	58	56
12	A	-	-	8	9	99	97	44	C	-	-	46	57	59	57
13	A	-	-	7	8	98	96	45	C	-	-	47	58	60	58
14	A	5	43	5	6	96	94	46	C	31	25	49	60	62	60
15	A	-	-	-	5	95	93	47	C	-	-	-	61	63	61
16	A	4	42	4	4	94	92	48/ TCK	C	32	26	50	62	64	62
17	B	21	15	33	41	39	37	49	D	33	27	51	63	65	63
18	B	-	-	-	40	38	36	50	D	-	-	-	64	66	64
19	B	20	14	32	39	37	35	51	D	34	28	52	65	67	65
20	B	19	13	30	37	35	33	52	D	36	30	54	67	69	67
21	B	18	12	29	36	34	32	53	D	37	31	55	68	70	68
22	B	-	-	28	35	33	31	54	D	-	-	56	69	71	69
23	B	-	-	-	34	32	30	55	D	-	-	-	70	73	71
24	B	17	11	27	33	31	29	56/ TDO	D	38	32	57	71	75	73
25	B	16	10	25	31	27	25	57	D	39	33	59	73	77	75
26	B	-	-	-	30	25	23	58	D	-	-	-	74	78	76
27	B	-	-	24	29	23	21	59	D	-	-	60	75	81	79
28	B	-	-	23	28	22	20	60	D	-	-	61	76	82	80
29	B	-	-	22	27	21	19	61	D	-	-	62	77	83	81
30	B	14	8	20	25	19	17	62	D	40	34	64	79	85	83
31	B	-	-	-	24	18	16	63	D	-	-	-	80	86	84
32/ TMS	B	13	7	19	23	17	15	64	D/ GCLK3	41	35	65	81	87	85

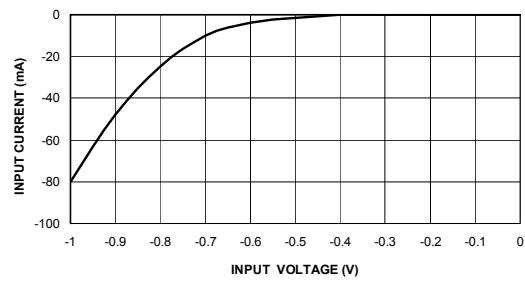
OUTPUT SINK CURRENT VS. OUTPUT VOLTAGE  
( $V_{CC} = 3.3V$ ,  $T_A = 25^\circ C$ )



INPUT CURRENT VS. INPUT VOLTAGE  
( $V_{CC} = 3.3V$ ,  $T_A = 25^\circ C$ )



INPUT CLAMP CURRENT VS. INPUT VOLTAGE  
( $V_{CC} = 3.3V$ ,  $T_A = 25^\circ C$ )



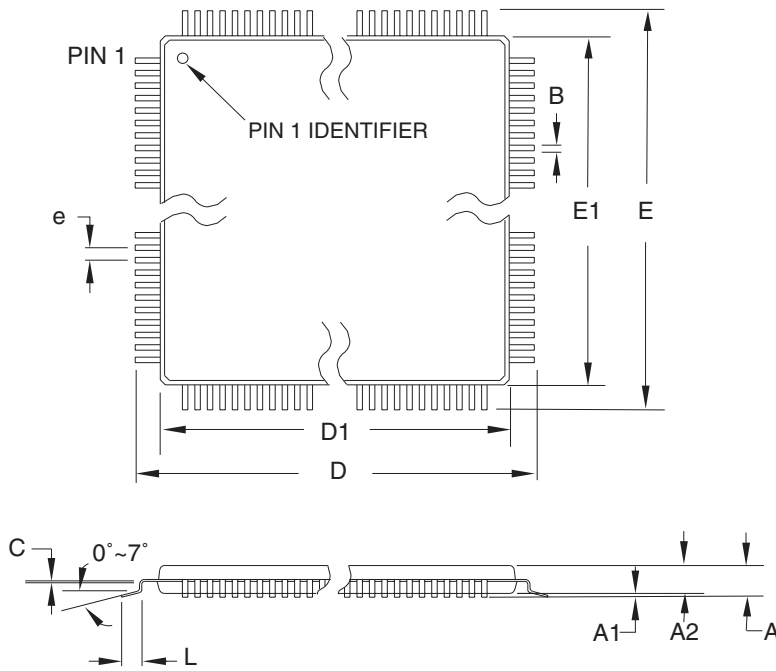
## ATF1504ASV(L) Green Package Options (Pb/Halide-free/RoHS Compliant)

$t_{PD}$ (ns)	$t_{CO1}$ (ns)	$f_{MAX}$ (MHz)	Ordering Code	Package	Operation Range
15	8	100	ATF1504ASV-15 AU44 ATF1504ASV-15 JU44 ATF1504ASV-15 AU100	44A 44J 100A	Industrial (-40°C to +85°C)
20	12	83.3	ATF1504ASVL-20 AU44 ATF1504ASVL-20 JU44 ATF1504ASVL-20 AU100	44A 44J 100A	Industrial (-40°C to +85°C)

Package Type	
<b>44A</b>	44-lead, Thin Plastic Gull Wing Quad Flatpack (TQFP)
<b>44J</b>	44-lead, Plastic J-leaded Chip Carrier (PLCC)
<b>68J</b>	68-lead, Plastic J-leaded Chip Carrier (PLCC)
<b>84J</b>	84-lead, Plastic J-leaded Chip Carrier (PLCC)
<b>100Q1</b>	100-lead, 14 x 20 mm Body, Plastic Quad Flat Package (PQFP)
<b>100A</b>	100-lead, 14 x 14 mm Body, Thin Profile Plastic Quad Flat Package (TQFP)

## Packaging Information

### 44A – TQFP



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	–	–	1.20	
A1	0.05	–	0.15	
A2	0.95	1.00	1.05	
D	11.75	12.00	12.25	
D1	9.90	10.00	10.10	Note 2
E	11.75	12.00	12.25	
E1	9.90	10.00	10.10	Note 2
B	0.30	–	0.45	
C	0.09	–	0.20	
L	0.45	–	0.75	
e	0.80 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-026, Variation ACB.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is 0.25 mm per side. Dimensions D1 and E1 are maximum plastic body size dimensions including mold mismatch.
  3. Lead coplanarity is 0.10 mm maximum.

10/5/2001



2325 Orchard Parkway  
San Jose, CA 95131

#### TITLE

**44A**, 44-lead, 10 x 10 mm Body Size, 1.0 mm Body Thickness,  
0.8 mm Lead Pitch, Thin Profile Plastic Quad Flat Package (TQFP)

#### DRAWING NO.

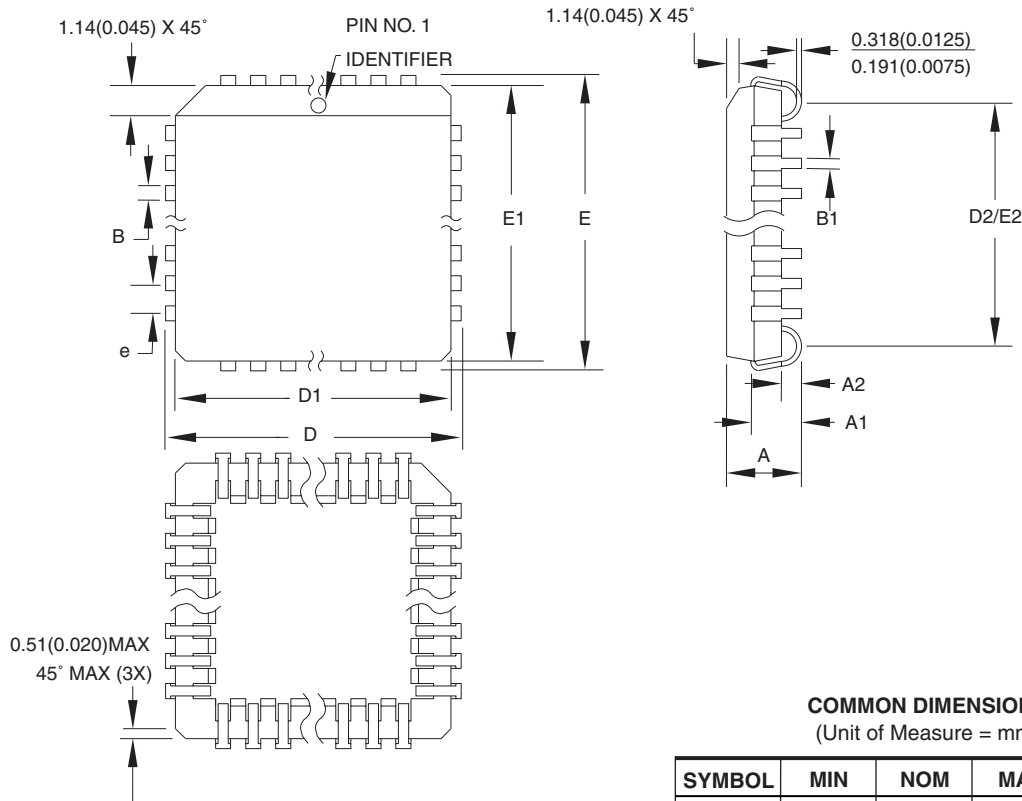
44A

#### REV.

B



## 44J – PLCC



- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AC.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	17.399	—	17.653	
D1	16.510	—	16.662	Note 2
E	17.399	—	17.653	
E1	16.510	—	16.662	Note 2
D2/E2	14.986	—	16.002	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

10/04/01



2325 Orchard Parkway  
San Jose, CA 95131

**TITLE**

**44J**, 44-lead, Plastic J-leaded Chip Carrier (PLCC)

**DRAWING NO.**

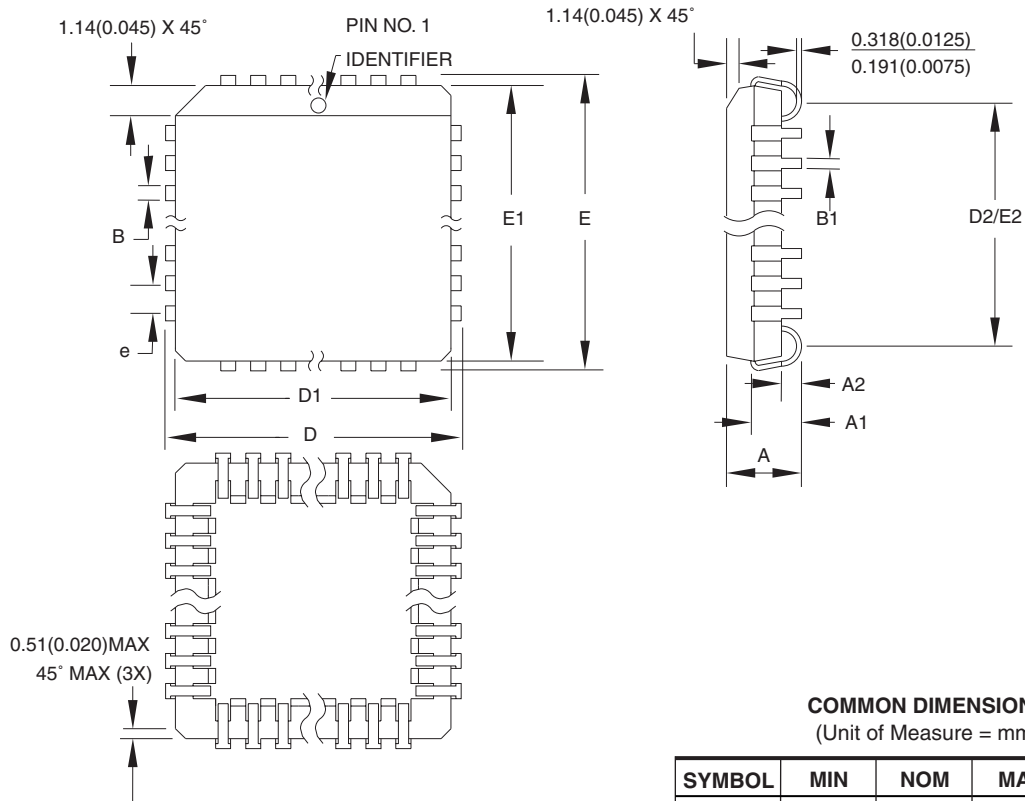
44J

**REV.**

B



## 68J – PLCC



- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AE.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



2325 Orchard Parkway  
San Jose, CA 95131

### TITLE

**68J, 68-lead, Plastic J-leaded Chip Carrier (PLCC)**

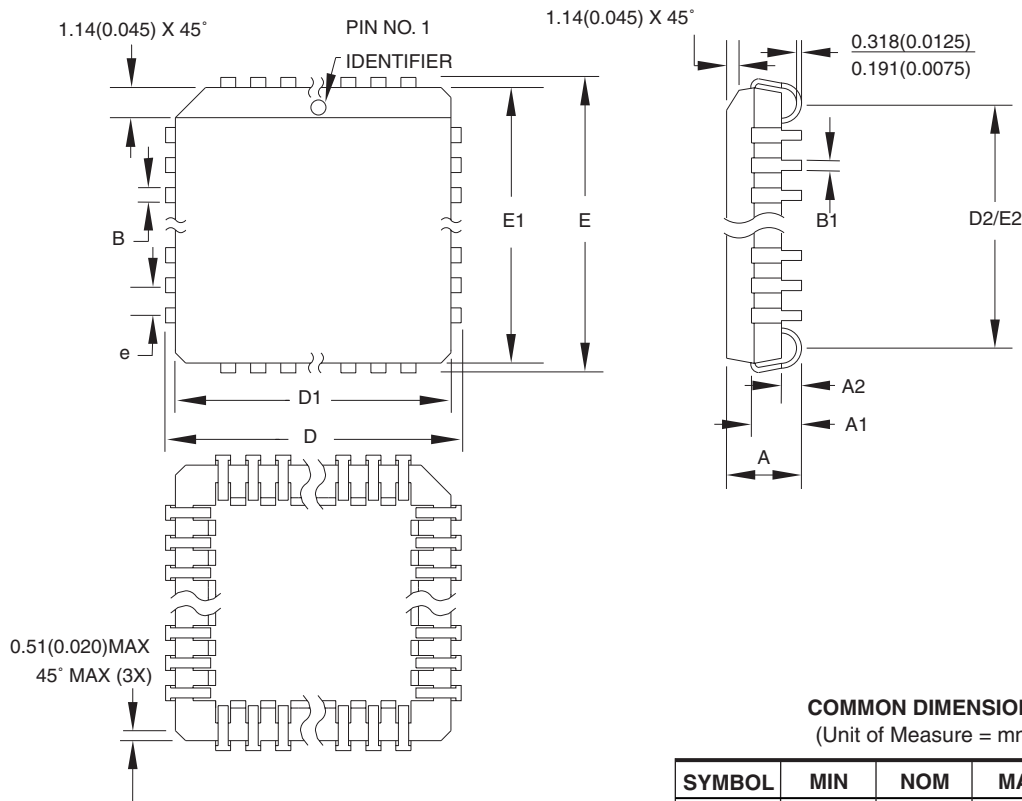
### DRAWING NO.

68J

### REV.

B

## 84J – PLCC



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	30.099	—	30.353	
D1	29.210	—	29.413	Note 2
E	30.099	—	30.353	
E1	29.210	—	29.413	Note 2
D2/E2	27.686	—	28.702	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AF.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



2325 Orchard Parkway  
San Jose, CA 95131

### TITLE

**84J**, 84-lead, Plastic J-leaded Chip Carrier (PLCC)

### DRAWING NO.

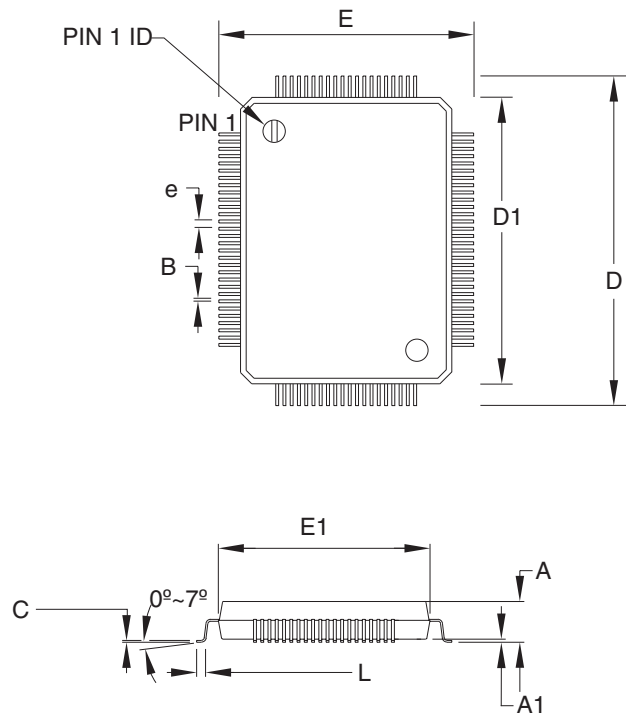
84J

### REV.

B



# 100Q1 – PQFP



## COMMON DIMENSIONS

(Unit of Measure = mm)

JEDEC STANDARD MS-022, GC-1

SYMBOL	MIN	NOM	MAX	NOTE
A	–	3.04	3.4	
A1	0.25	0.33	0.5	
D	23.20 BSC			
E	17.20 BSC			
E1	14.00 BSC			
B	0.22	–	0.40	
D1	20 BSC			
L	0.73	–	1.03	
e	0.65 BSC			

09/10/2002



2325 Orchard Parkway  
San Jose, CA 95131

## TITLE

**100Q1**, 100-lead, 14 x 20 mm Body, 3.2 mm Footprint, 0.65 mm Pitch,  
Plastic Quad Flat Package (PQFP)

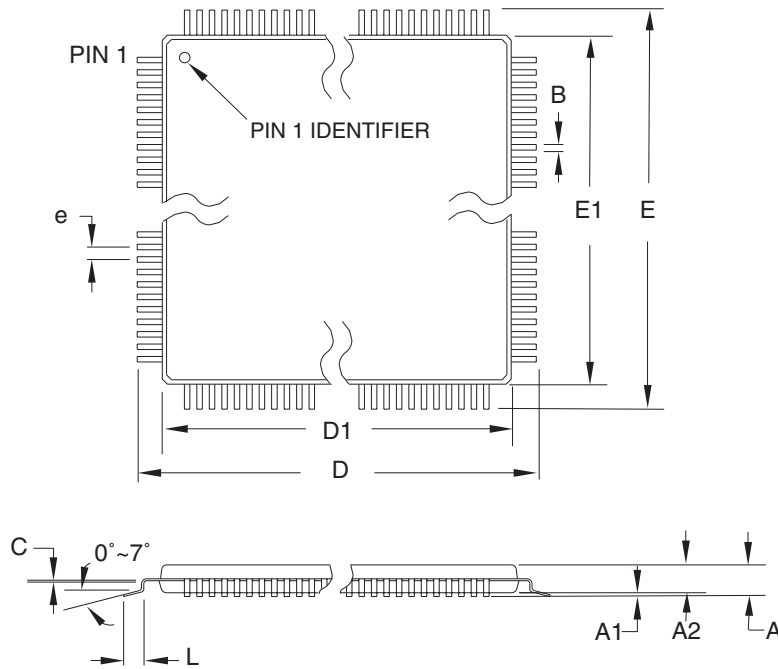
## DRAWING NO.

100Q1

## REV.

B

100A – TQFP



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	—	—	1.20	
A1	0.05	—	0.15	
A2	0.95	1.00	1.05	
D	15.75	16.00	16.25	
D1	13.90	14.00	14.10	Note 2
E	15.75	16.00	16.25	
E1	13.90	14.00	14.10	Note 2
B	0.17	—	0.27	
C	0.09	—	0.20	
L	0.45	—	0.75	
e	0.50 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-026, Variation AED.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is 0.25 mm per side. Dimensions D1 and E1 are maximum plastic body size dimensions including mold mismatch.
  3. Lead coplanarity is 0.08 mm maximum.

10/5/2001



2325 Orchard Parkway  
San Jose, CA 95131

**TITLE**

**100A**, 100-lead, 14 x 14 mm Body Size, 1.0 mm Body Thickness,  
0.5 mm Lead Pitch, Thin Profile Plastic Quad Flat Package (TQFP)

**DRAWING NO.**

100A

**REV.**

C

